

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/820,188 | Applicant(s)/Patent Under Reexamination BECKMANN ET AL. | |
| | Examiner Imran Akram | Art Unit 1709 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | A | US-2003/0170514 A1 | 09-2003 | Faye et al. | 429/19 |
| * | B | US-2002/0098394 A1 | 07-2002 | Keefer et al. | 429/13 |
| * | C | US-6,609,582 B1 | 08-2003 | Botti et al. | 180/65.3 |
| * | D | US-2004/0142215 A1 | 07-2004 | Barbir et al. | 429/013 |
| * | E | US-4,461,224 | 07-1984 | Michelfelder et al. | 110/345 |
| * | F | US-2002/0085963 A1 | 07-2002 | Vidalin, Kenneth Ebenes | 422/187 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.